



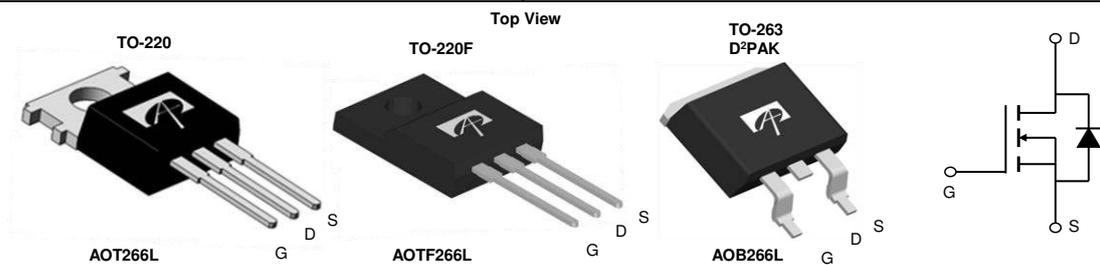
**General Description**

The AOT266L & AOB266L & AOTF266L uses Trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of  $R_{DS(ON)}$ ,  $C_{iss}$  and  $C_{oss}$ . This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

**Product Summary**

$V_{DS}$	60V
$I_D$ (at $V_{GS}=10V$ )	140A/78A
$R_{DS(ON)}$ (at $V_{GS}=10V$ )	< 3.5m $\Omega$ (< 3.2m $\Omega^*$ )
$R_{DS(ON)}$ (at $V_{GS}=6V$ )	< 4.0m $\Omega$ (< 3.8m $\Omega^*$ )

100% UIS Tested  
100%  $R_g$  Tested



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOT266L	TO220 Green	Tube	1000
AOTF266L	TO220F Green	Tube	1000
AOB266L	TO263 Green	Tape & Reel	800

**Absolute Maximum Ratings  $T_A=25^\circ C$  unless otherwise noted**

Parameter	Symbol	AOT266L/AOB266L	AOTF266L	Units	
Drain-Source Voltage	$V_{DS}$	60		V	
Gate-Source Voltage	$V_{GS}$	$\pm 20$		V	
Continuous Drain Current <sup>G</sup>	$I_D$	140	78	A	
$T_C=100^\circ C$		110	55		
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	450			
Continuous Drain Current	$I_{DSM}$	$T_A=25^\circ C$	18	A	
		$T_A=70^\circ C$	14		
Avalanche Current <sup>C</sup>	$I_{AS}$	90		A	
Avalanche energy $L=0.1mH$ <sup>C</sup>	$E_{AS}$	405		mJ	
Power Dissipation <sup>B</sup>	$P_D$	$T_C=25^\circ C$	268	45.5	W
		$T_C=100^\circ C$	134	22.5	
Power Dissipation <sup>A</sup>	$P_{DSM}$	$T_A=25^\circ C$	2.1	W	
		$T_A=70^\circ C$	1.3		
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 175		$^\circ C$	

**Thermal Characteristics**

Parameter	Symbol	AOT266L/AOB266L	AOTF266L	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	15	15	$^\circ C/W$
Maximum Junction-to-Ambient <sup>A,D</sup>		60	60	
Maximum Junction-to-Case	$R_{\theta JC}$	0.56	3.3	$^\circ C/W$

\* Surface mount package TO263

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	60			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V T <sub>J</sub> =55°C			1 5	μA
I <sub>GSS</sub>	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2.2	2.7	3.2	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A TO220/TO220F T <sub>J</sub> =125°C		2.9	3.5	mΩ
		V <sub>GS</sub> =6V, I <sub>D</sub> =20A TO220/TO220F		4.9	5.9	mΩ
		V <sub>GS</sub> =6V, I <sub>D</sub> =20A TO263		3.2	4	mΩ
		V <sub>GS</sub> =10V, I <sub>D</sub> =20A TO263		2.6	3.2	mΩ
		V <sub>GS</sub> =6V, I <sub>D</sub> =20A TO263		3	3.8	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =20A		80		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V		0.65	1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Current <sup>G</sup>				140	A
<b>DYNAMIC PARAMETERS</b>						
C <sub>iss</sub>	Input Capacitance			5650		pF
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =30V, f=1MHz		720		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			20		pF
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	0.4	0.9	1.4	Ω
<b>SWITCHING PARAMETERS</b>						
Q <sub>g</sub> (10V)	Total Gate Charge			65	90	nC
Q <sub>gs</sub>	Gate Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =20A		20		nC
Q <sub>gd</sub>	Gate Drain Charge			7		nC
t <sub>D(on)</sub>	Turn-On Delay Time			21		ns
t <sub>r</sub>	Turn-On Rise Time	V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, R <sub>L</sub> =1.5Ω, R <sub>GEN</sub> =3Ω		20		ns
t <sub>D(off)</sub>	Turn-Off Delay Time			36		ns
t <sub>f</sub>	Turn-Off Fall Time			6		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, di/dt=500A/μs		27		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =20A, di/dt=500A/μs		145		nC

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=175° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=175° C. The SOA curve provides a single pulse rating.

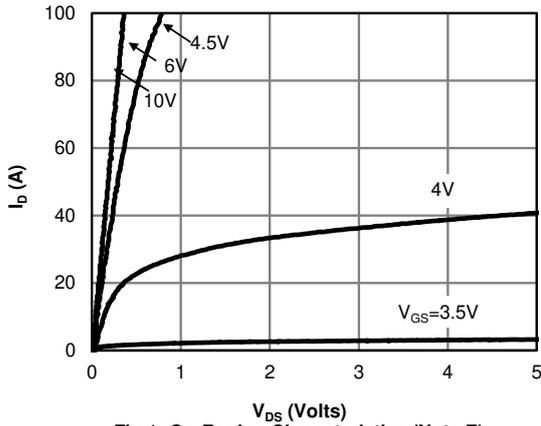
G. The maximum current limited by package.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

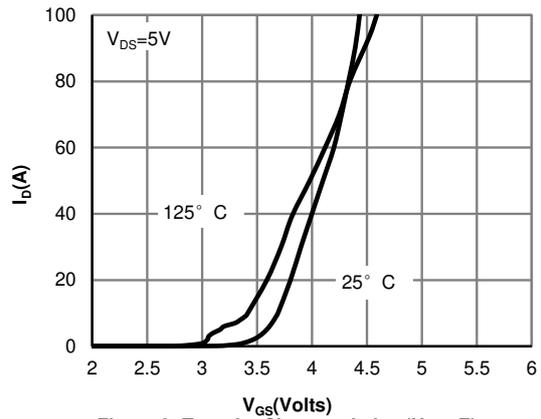
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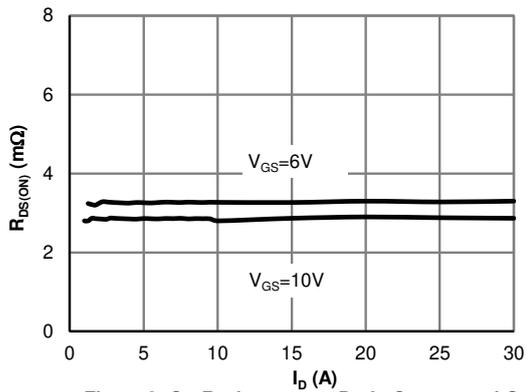
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



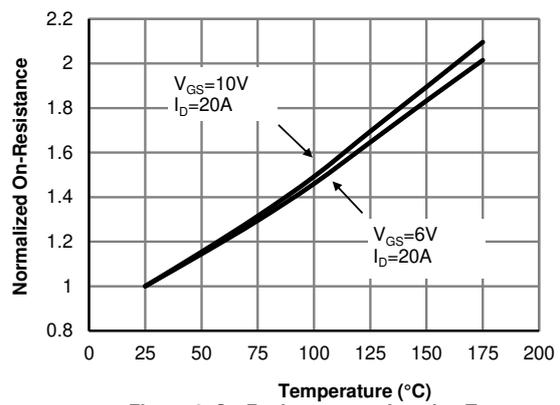
**Fig 1: On-Region Characteristics (Note E)**



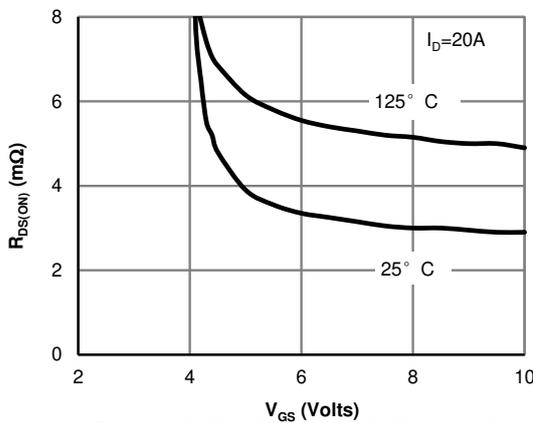
**Figure 2: Transfer Characteristics (Note E)**



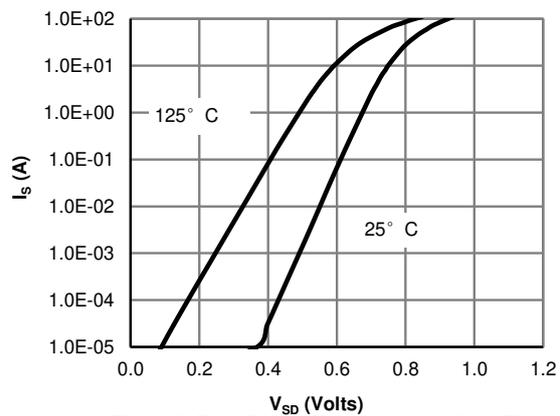
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

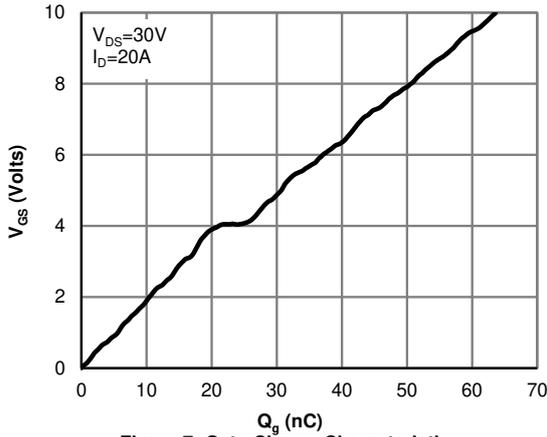


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

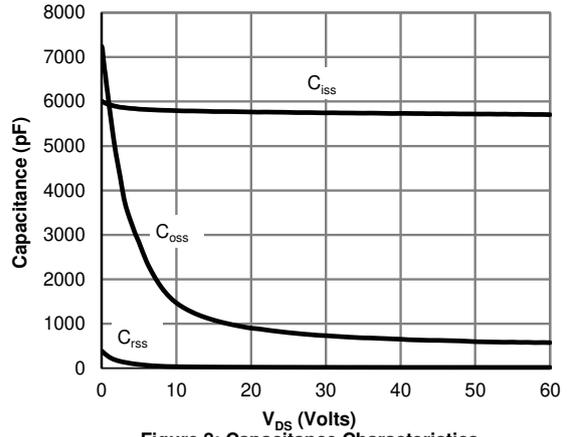


**Figure 6: Body-Diode Characteristics (Note E)**

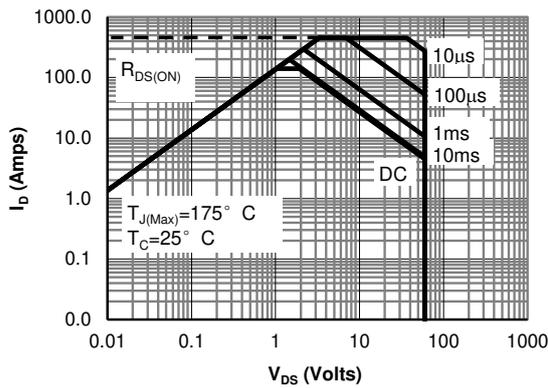
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



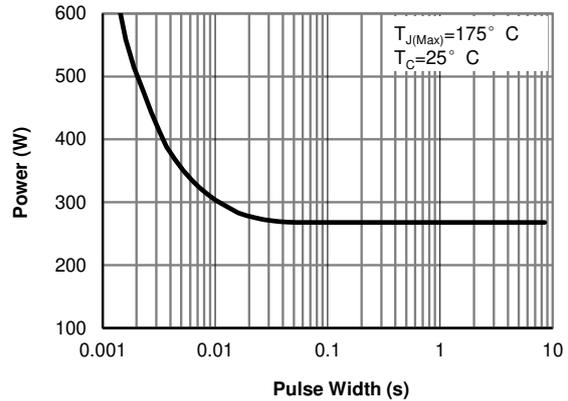
**Figure 7: Gate-Charge Characteristics**



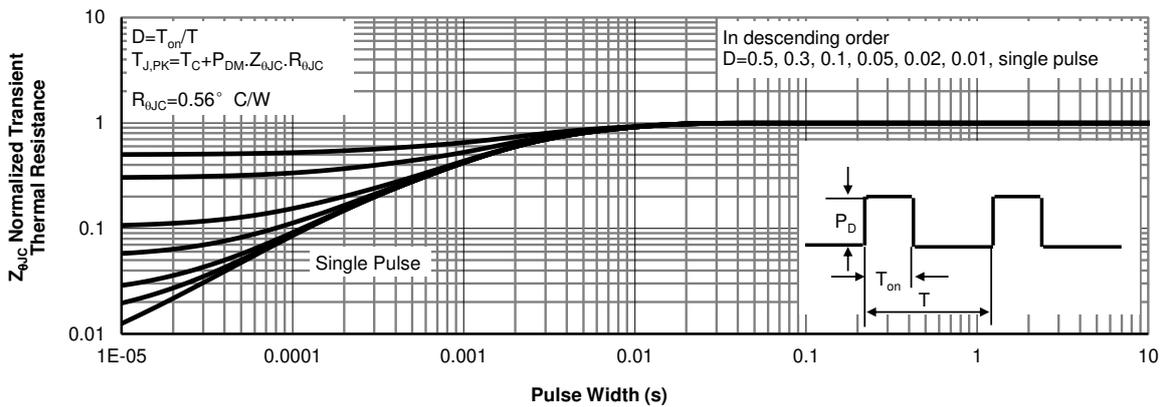
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area for AOT266L and AOB266L (Note F)**

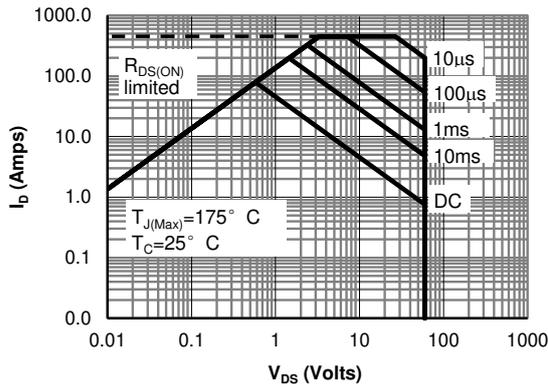


**Figure 10: Single Pulse Power Rating Junction-to-Case for AOT266L and AOB266L (Note F)**

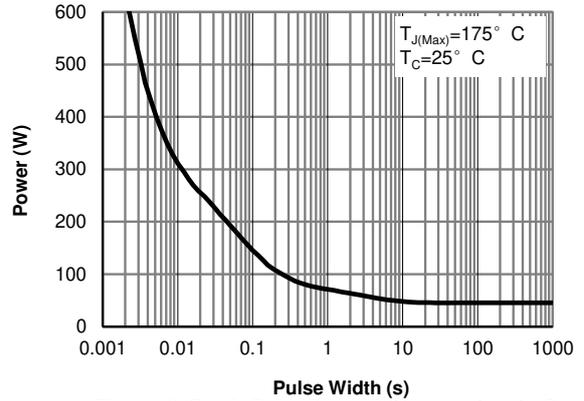


**Figure 11: Normalized Maximum Transient Thermal Impedance for AOT266L and AOB266L (Note F)**

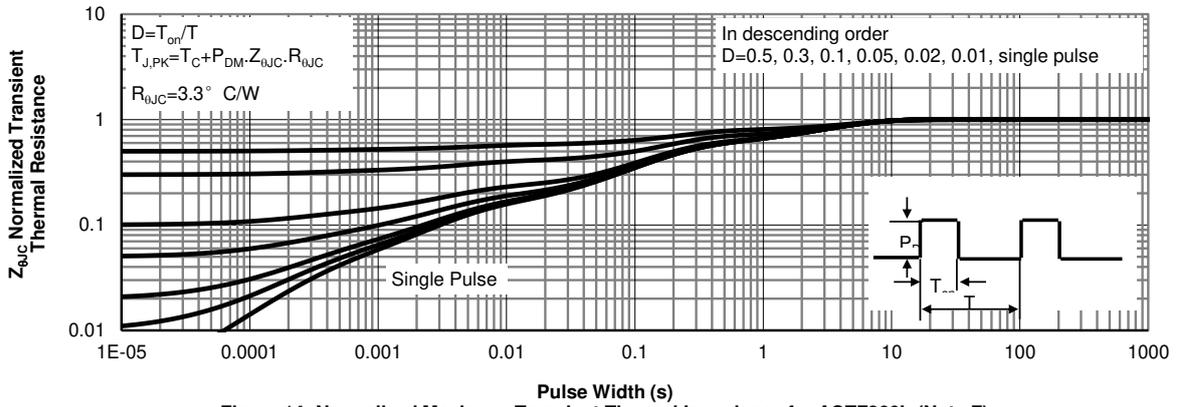
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



**Figure 12: Maximum Forward Biased Safe Operating Area for AOTF266L (Note F)**

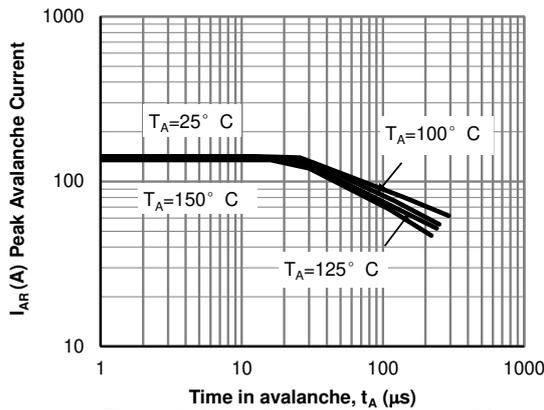


**Figure 13: Single Pulse Power Rating Junction-to-Case for AOTF266L (Note F)**

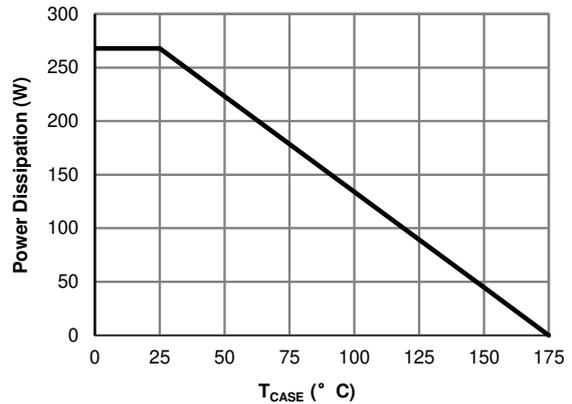


**Figure 14: Normalized Maximum Transient Thermal Impedance for AOTF266L (Note F)**

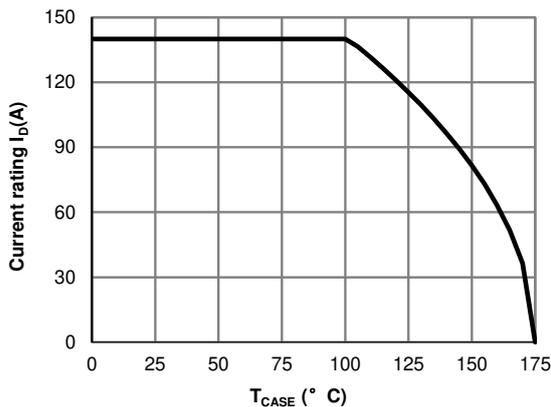
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



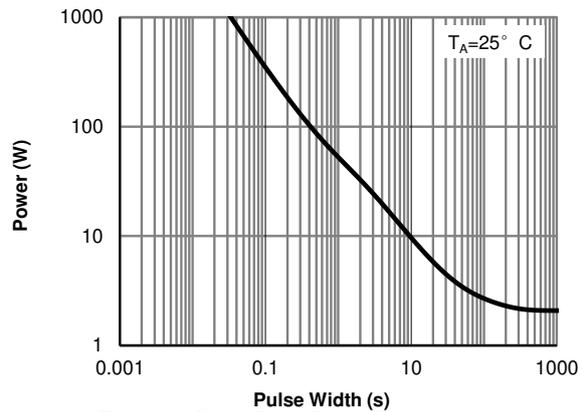
**Figure 15: Single Pulse Avalanche capability (Note C)**



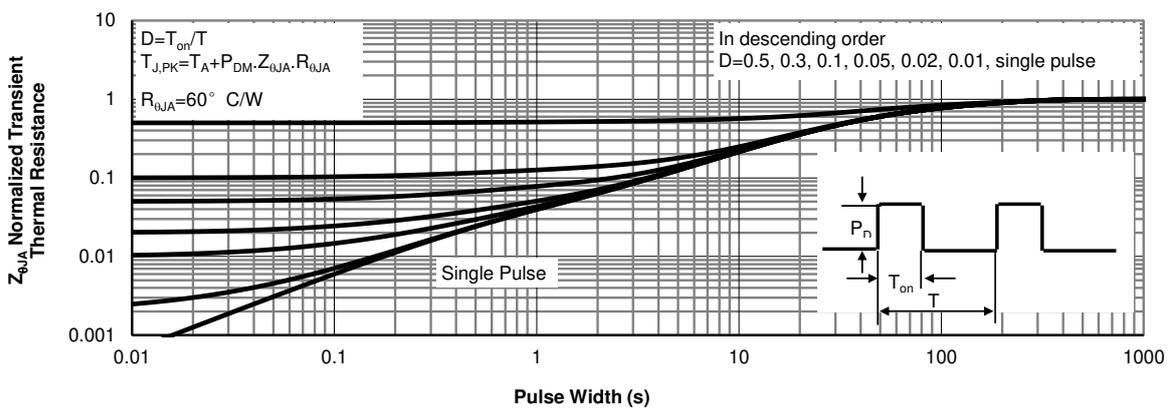
**Figure 16: Power De-rating (Note F)**



**Figure 17: Current De-rating (Note F)**

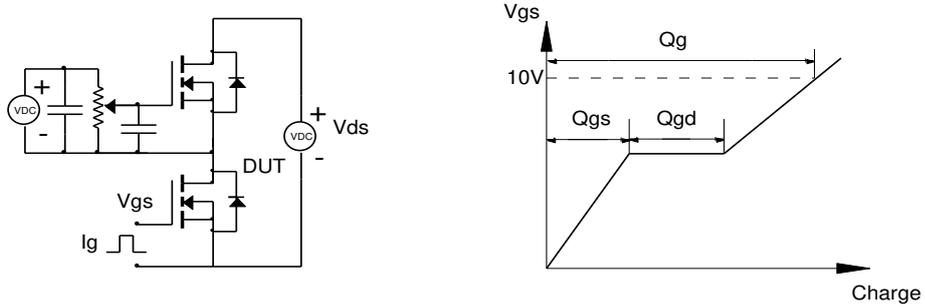


**Figure 18: Single Pulse Power Rating Junction-to-Ambient (Note H)**

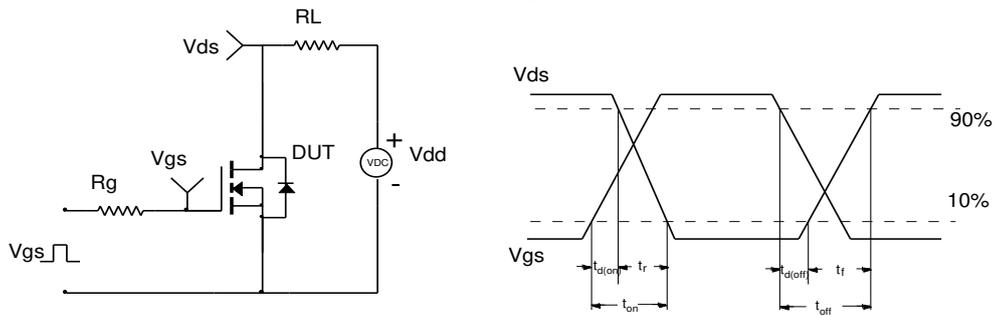


**Figure 19: Normalized Maximum Transient Thermal Impedance (Note H)**

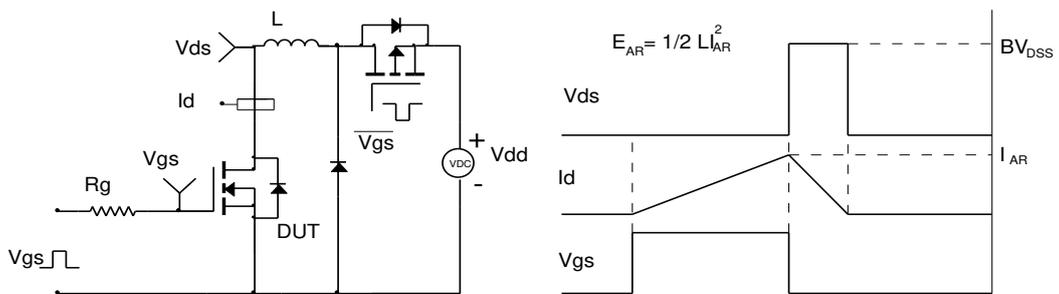
**Gate Charge Test Circuit & Waveform**



**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**



**Diode Recovery Test Circuit & Waveforms**

